

TEST REPORT

Applicant: NINGBO JIANGBEI REALSHINE ELECTRONICS CO., LTD
Address: 4F, 1 Building, No.6 Hongxing Rd, Hongtang Street, Jiangbei District, Ningbo City
Equipment Type: READING LAMP Remote control
Model Name: RS-DW31/RS-DW32/RS-DW52/RS-DW63/RS-DW64
Brand Name: N/A
Test Standard: IEEE Std 149-2021
Sample Arrival Date: Sep. 05, 2024
Test Date: Sep. 06, 2024
Date of Issue: Oct. 14, 2024

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

Tested by: Mai Jintian

Checked by: Xia Long

Approved by: Tolan Tu
(Testing Director)

Mai Jintian

Xia Long

Tolan Tu

Revision History

Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>Oct. 14, 2024</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	☒ Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☐ 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	NINGBO JIANGBEI REALSHINE ELECTRONICS CO., LTD
Address	4F, 1 Building, No.6 Hongxing Rd, Hongtang Street, Jiangbei District, Ningbo City

2.2 Manufacturer Information

Manufacturer	N/A
Address	N/A

2.3 General Description for Equipment under Test (EUT)

EUT Name	READING LAMP Remote control
Model Name Under Test	RS-DW31/RS-DW32/RS-DW52/RS-DW63/RS-DW64
Antenna Type	PCB Antenna
Dimensions	69*29 mm

2.4 Ancillary Equipment

Note: Not applicable.

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	IEEE Std 149-2021	IEEE Standard Test Procedures for Antennas

3.2 Test Verdict

Report Section	Description	Remark
ANNEX A.1	Gain and Efficiency	Note
ANNEX A.2	VSWR	Note
ANNEX B	Radiation Pattern	Note
Note: Compared with the EUT of test report BL-SZ2490277-901, the EUT of this report shows different things as below: 1. Updated the EUT name. Other hardware circuit and software are the same as EUT referred to in test report BL-SZ2490277-901. Therefore, in addition to the above differences, all test data and EUT information are derived from the report BL-SZ2490277-901 published by Shenzhen BALUN Technology Co., Ltd. on Sep. 20, 2024.		

3.3 Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Item	Uncertainty
VSWR(S11)	± 0.61
Gain	$\pm 1.92\text{dB}$

4 GENERAL TEST CONFIGURATIONS

4.1 Test Condition

Environment Parameter	Selected Values During Tests			
	Ambient Pressure(KPa)	Temperature(°C)	Voltage	Relative Humidity (%)
Normal Temperature, Normal Voltage (NTNV)	101	21.7	N/A	44

4.2 Test Equipment List

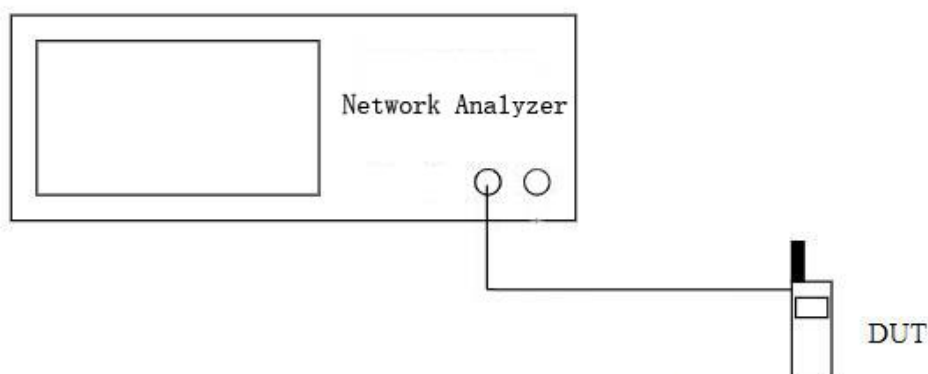
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
SG24 Multi-probe Antenna Measurement System	SATIMO	SG24-L	1101855- 0001	2021.11.12	2024.11.11
Vector Network Analyzer	Agilent	E5071B	MY42404001	2024.01.16	2025.01.15
Description	Manufacturer	Name		Version	
Test Software	MVG	SPM		V 1.8	

4.3 Test Setup

4.3.1 Antenna gain, efficiency and radiation pattern test setup



4.3.2 S11 parameter test setup



4.4 Test Frequencies

Test Frequencies	430MHz, 431MHz, 432MHz, 433MHz, 434MHz, 435MHz, 436MHz, 437MHz, 438MHz, 439MHz, 440MHz
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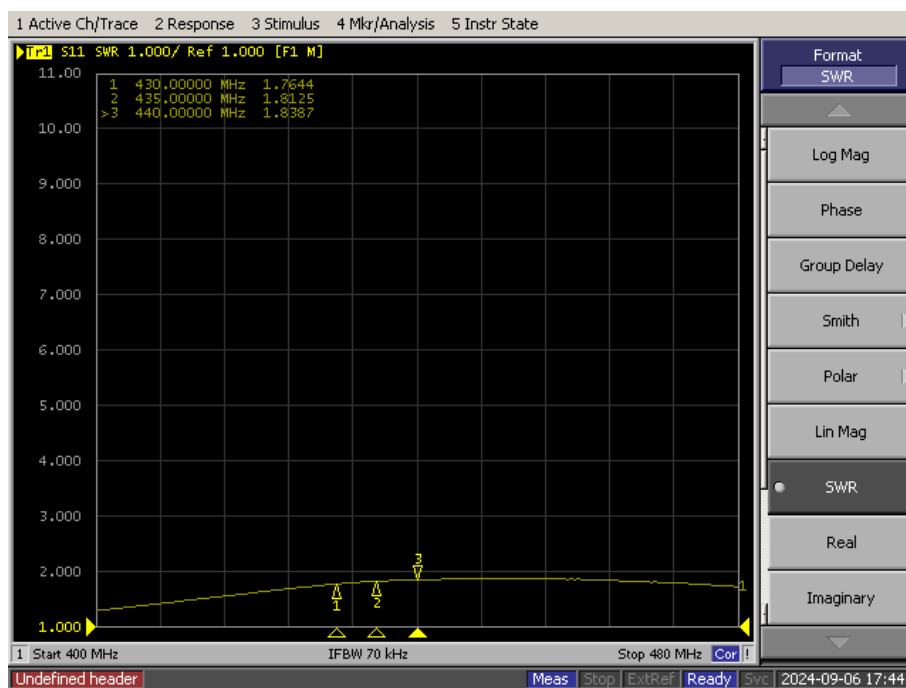
ANNEX A TEST RESULTS

A.1 Gain and Efficiency

Frequency	Gain (dBi)	Efficiency (%)
430MHz	-2.93	16
431MHz	-3.08	16
432MHz	-3.17	15
433MHz	-3.28	15
434MHz	-3.47	15
435MHz	-4.04	14
436MHz	-4.24	14
437MHz	-4.33	13
438MHz	-4.42	13
439MHz	-4.50	13
440MHz	-4.51	13

A.2 VSWR

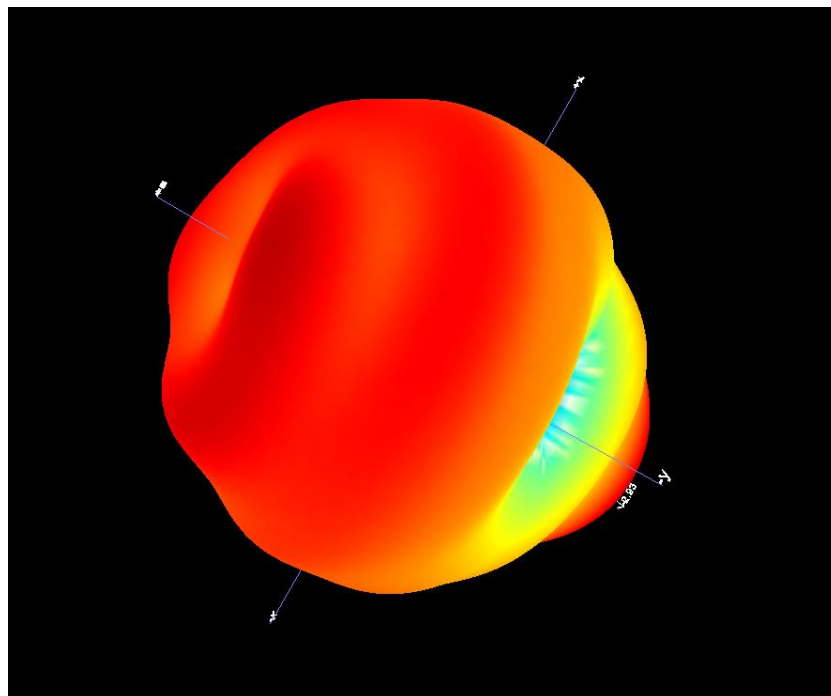
Frequency	VSWR
430MHz	1.76
435MHz	1.81
440MHz	1.84



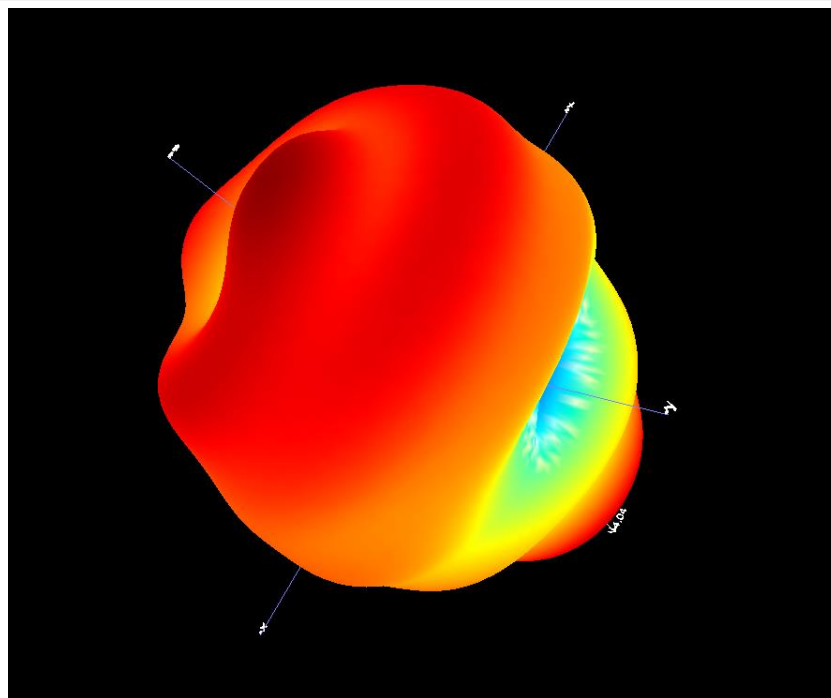
ANNEX B RADIATION PATTERN

B.1 3D Pattern

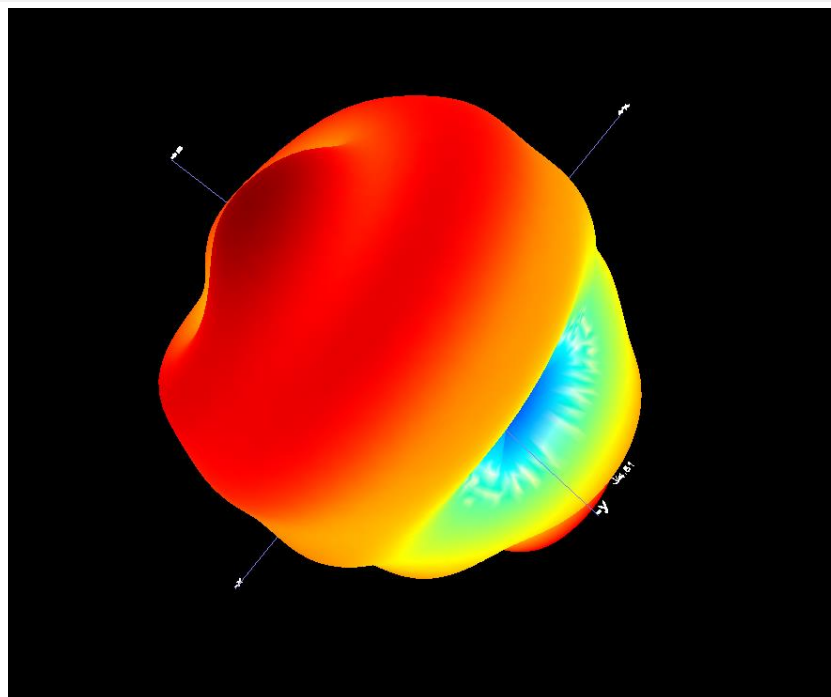
B1.1 3D Pattern for 430MHz



B1.2 3D Pattern for 435MHz

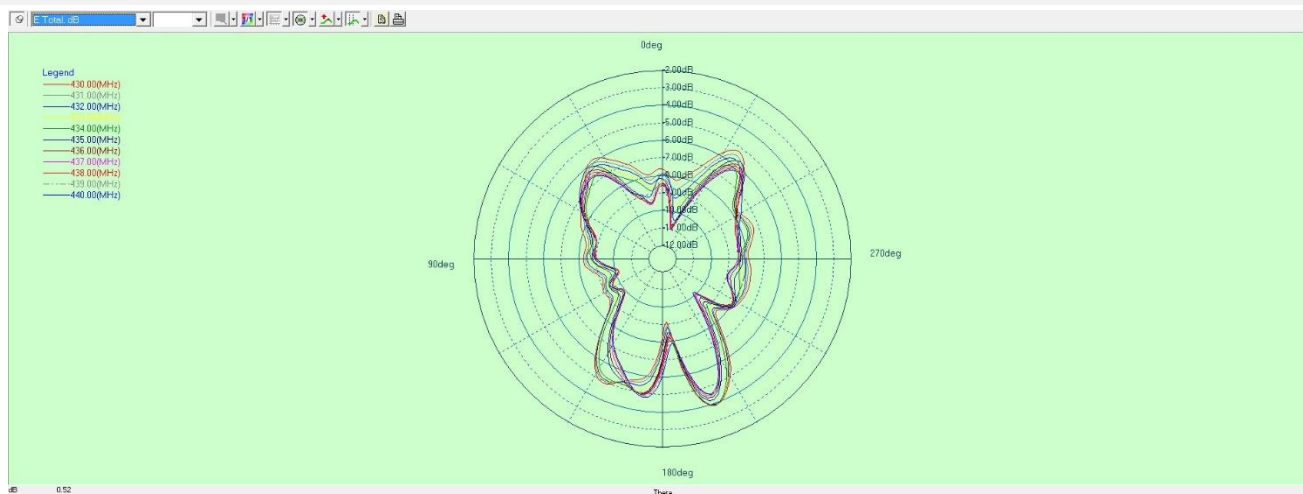


B1.3 3D Pattern for 440MHz

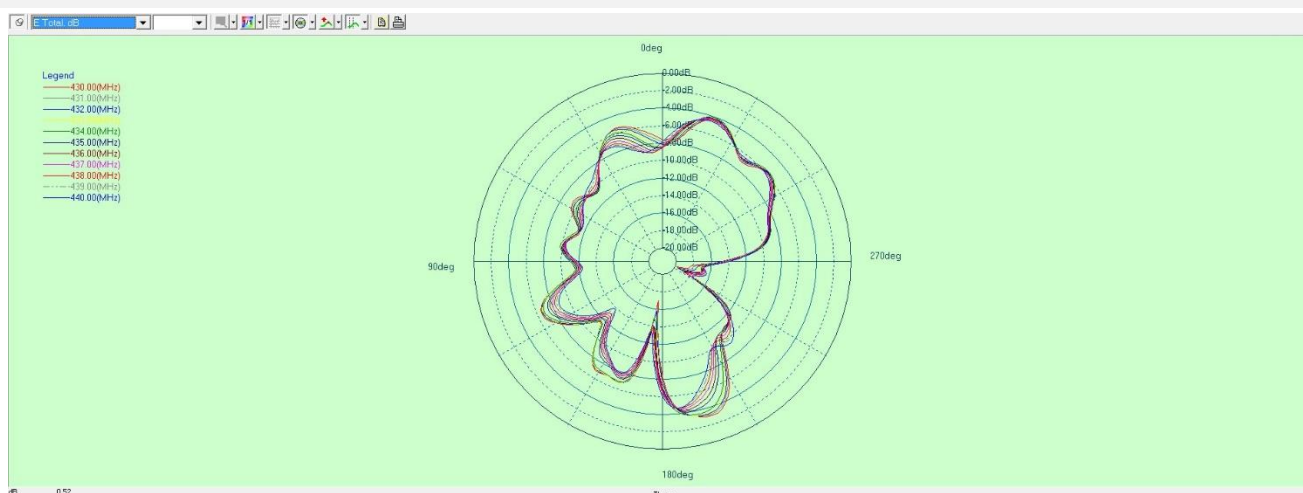


B.2 1D Radiation Pattern

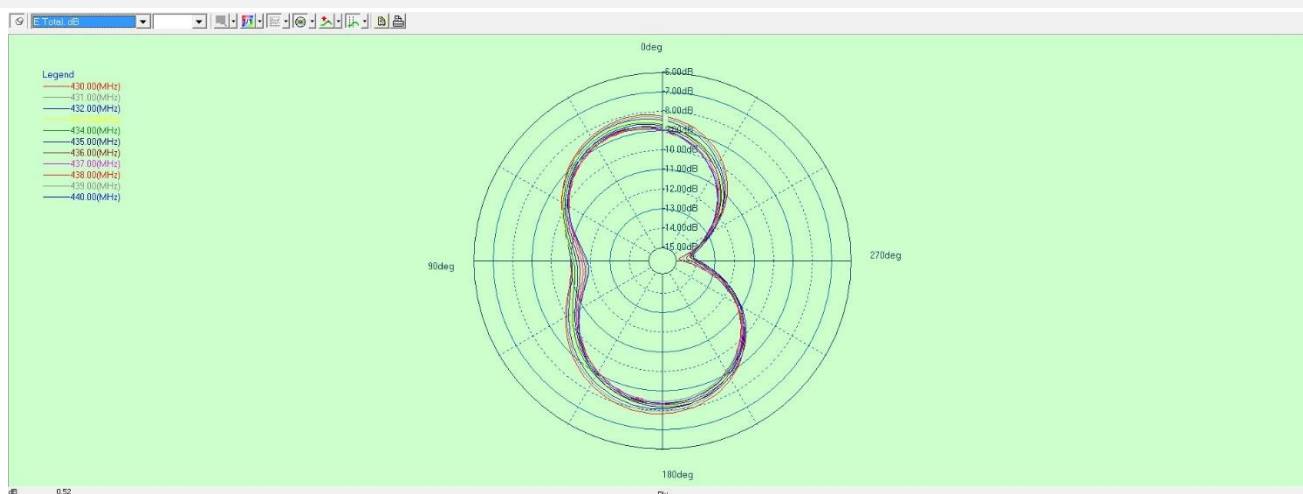
B2.1 PHI=0



B2.2 PHI=90



B2.3 THETA=90



ANNEX C TEST SETUP PHOTOS

Please refer the document “BL-SZ24A0157-AO.PDF”.

ANNEX D EUT PHOTO

Please refer the document “BL-SZ24A0157-AA.PDF”.

Statement

1. The laboratory guarantees the scientificity, accuracy and impartiality of the test, and is responsible for all the information in the report, except the information provided by the customer. The customer is responsible for the impact of the information provided on the validity of the results.
2. The report without China inspection body and laboratory Mandatory Approval (CMA) mark has no effect of proving to the society.
3. For the report with CNAS mark or A2LA mark, the items marked with "☆" are not within the accredited scope.
4. This report is invalid if it is altered, without the signature of the testing and approval personnel, or without the "inspection and testing dedicated stamp" or test report stamp.
5. The test data and results are only valid for the tested samples provided by the customer.
6. This report shall not be partially reproduced without the written permission of the laboratory.
7. Any objection shall be raised to the laboratory within 30 days after receiving the report.

--END OF REPORT--